

REMARKS

Claims 1-20 have been cancelled. Claim 23 has been added. Claim 23 remains for further consideration. No new matter has been added.

The objections and rejections shall be taken up in the order presented in the Official Action.

1. The Official Action contends that the priority document has not yet been submitted. However, the prior document DE 103 05 972.5 was submitted to the USPTO on July 13, 2004 along with a Certificate of First Class mailing. Attached please find a copy of the postcard indicating the USPTO's receipt of the prior document and a copy of the cover page of the priority document.

2. Entry of the IDS is noted and appreciated.

3. A replacement Abstract is enclosed.

4. Claims 1-20 currently stand rejected under 35 U.S.C. §112, second paragraph for allegedly failing to particularly point out and distinctly claim the subject matter deemed to be the present invention.

Claims 1-20 have been cancelled.

5. Claims 1-20 currently stand rejected for allegedly being anticipated by the subject matter disclosed in U.S. Patent 6,639,537 to Raz (hereinafter "Raz").

Claims 1-20 have been cancelled. Claim 23 has been added. Claim 23 recites a system for compensating for distortion within an analog-to-digital converter. The system includes:

“a test signal generator that provides an analog test signal and a digitized test signal indicative of the analog test signal;
an analog-to-digital converter that selectively receives an input signal and the analog test signal and provides a digitized signal;
a compensation circuit that receives the digitized signal and adaptive filter coefficients, and provides a compensated digitized signal;
a test signal check device that receives and processes the compensated digital signal to extract a sequence of output data;
a difference unit that receives the sequence of output data and the compensated digital signal and provides a difference signal indicative of the difference; and
a coefficient determination unit that receives the difference signal and the digitized signal and provides adaptive filter coefficients.” (emphasis added, cl. 23).

Raz neither discloses such a test signal check device that processes the compensated digital signal to extract a sequence of output data is compared in a difference unit with the compensated digital signal in order to provide a difference signal that is used to compute the adaptive filter coefficients. Accordingly, it is respectfully submitted that Raz is incapable of anticipating or rendering obvious the subject matter recited in claim 23.

For all the foregoing reasons, reconsideration and allowance of claim 23 is respectfully requested.

If a telephone interview could assist in the prosecution of this application, please call the undersigned attorney.

Respectfully submitted,



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KCOMPENSATION CIRCUIT AND ~~COMPENSATION~~ METHOD TO COMPENSATE NONLINEAR DISTORTIONS OF AN A/D CONVERTER

BACKGROUND OF THE INVENTION

The invention relates to the field of analog-to-digital signal conversion, and in particular to a compensation circuit to compensate nonlinear distortions of an analog-to-digital (A/D) converter. ~~(A/D: analog/digital) having the features listed in the preamble of Claim 1, and to a compensation method to compensate nonlinear distortions of an A/D converter.~~

A/D converters are a critical component in integrated circuits having mixed signal processing, (i.e., analog and digital signal processing). Requirements related to the linearity of the A/D converter are quite difficult to achieve given the usual tolerances for analog components. The measures required for this purpose in the area of analog design entail high cost and/or high current consumption by the circuit.

In order to prevent nonlinear distortions in the analog-to-digital conversion process of the A/D converter, compensation circuits are employed to compensate for these nonlinear distortions of the A/D converter. ~~These compensation circuits haveing an analog signal input, and are typically located. Usually, they are a component~~ on the input side of the A/D converter.

~~The goal of the invention is therefore to propose~~ There is a need for a compensation circuit that to compensates for nonlinear distortions of an A/D converter, and requires a which circuit ~~provides for a~~ simplified overall analog design together with, preferably, reduced current consumption.

SUMMARY OF THE INVENTION

~~This goal is achieved by a compensation circuit to compensate nonlinear distortions of an A/D converter having the features of Claim 1 and by a method to compensate nonlinear distortions of an A/D converter having the features of Claim 18.~~

A compensation circuit to compensate nonlinear distortions of an A/D converter may include advantageously have a signal input and a compensation circuit composed of digital circuit elements to digitally compensate nonlinear distortions, the signal input as the compensation input being a digital signal input to supply a signal outputted in distorted form by the A/D converter. Implementation is thus in the form of an output-side digital compensation or distortion correction of the nonlinear distortions from an input-side A/D converter. The digital circuit elements required for this purpose are inexpensive and readily available based on a simple digital circuit design. Advantageously, it is no longer necessary to incur high costs or have increased current consumption based on a compensation circuit added on the input-side of, or integrated into, the A/D converter.

~~According to the method, after analog to digital conversion within the A/D converter and a nonlinearly distorted digital signal is outputted, compensation is implemented in the digital circuit segment.~~

~~Advantageous embodiments are the subject of the dependent claims.~~

BRIEF DESCRIPTION OF THE DRAWINGS

~~An embodiment and modifications thereof will be explained in greater detail with reference to the drawing.~~

~~Figure FIG. 1 is a block diagram illustration of a shows basic elements of the compensation circuit to compensate for nonlinear distortions of an A/D converter;~~

~~FIG. figure 2 is a block diagram illustration of shows a circuit to determine a test signal;~~

FIG. figure 3 is a block diagram illustration of shows a circuit for the iterative calculation of correction coefficients; and

FIG. figure 4 is a block diagram illustration of shows an alternative circuit for the iterative calculation of correction coefficients using a look-up table.

DETAILED DESCRIPTION OF THE INVENTION

FIG. 1 is a block diagram illustration of a compensation circuit to compensate for nonlinear distortions of an A/D converter. ~~As is evident from Figure 1, t~~The compensation circuit in the example is composed of an analog section, shown at left, and a digital section shown on the right. An analog input signal $x(t)$ is supplied to an A/D converter ADC/1, which provides (A/D: analog-to-digital). ~~After analog-to-digital conversion, a digital sequence of characters x_n is outputted from the output of A/D converter 1, which sequence correspondings to the analog input signal $x(t)$.~~ When a conventional A/D converter 1 is used, the digital sequence x_n from this converter exhibits nonlinear distortion. The index n represents the sequence of sampling values x_n , $n = 0, 1, 2, \dots$

The A/D-converted sequence x_n is ~~then fed to the input of a compensation circuit 2, Compensation circuit 2 which~~ compensates or corrects the nonlinear distortion ~~which has been created by the A/D converter 1. The compensation circuit 2 provides~~ Finally, a sequence of compensated digital data y_n ~~is outputted from compensation circuit 2 as the output data sequence.~~

~~In order to be able to implement the compensation, The compensation circuit 2 receives~~ coefficients $c_1, c_2, \dots, c_K, c_0$ ~~are supplied to compensation circuit 2 which that~~ have been determined or calculated based on the nonlinear distortion response of the A/D converter 1. The index $k = 1, 2, \dots, K$ here functions as the consecutive index for the coefficients c_k of compensation.

The circuit of this design ~~includes an~~ consisting of A/D converter 1 together with the ~~following compensation circuit 2 to which a set of coefficients $c_1, \dots c_K$ is supplied thus offers a~~ simple design which enables an analog-to-digital conversion of an analog signal $x(t)$ to form a sequence of compensated digital data y_n which does not suffer from nonlinear distortion.

~~Additional components of the circuit, shown in the segment enclosed by the broken line, serve the purpose of~~ A coefficient computation unit 100 determines the coefficients $c_1, \dots c_K$.

These additional components are advantageously active only during a configuration phase. As an alternative to the circuit described below, it is also possible to employ a memory in which a set of coefficients $c_1, \dots c_K$, determined previously only once, is stored which may be applied generally for the compensation. ~~However, The preferred approach, however,~~ is the circuit design described below which provides an adjustment of the coefficients $c_1, \dots c_K$ to the actual and/or instantaneous conditions.

Referring to FIG. 1, In the circuit shown in the example, a test signal $s(t)$ is generated by a test signal generator 3 and applied during the configuration phase to the input of the A/D converter 1. ~~The~~ The test signal generator 3 also provides either the parameters s_n to generate the analog test signal $s(t)$ or a sequence of digital test signal data S_n corresponding to this analog test signal $s(t)$. These parameters s_n or test signal data S_n are fed to a coefficient determination system 5 and/or to a test signal check device 4.

~~In addition, the circuit has a~~ The coefficient determination system 5 ~~to determines~~ the coefficients $c_1, \dots c_K$ to be used by the compensation circuit 2. ~~In addition to an output to transmit the determined coefficients $c_1, \dots c_K, c_0$ to compensation circuit 2,~~ The coefficient determination system 5 receives the ~~has an input to which the sequence of digital data x_n from the A/D converter 1, is supplied. In addition,~~ The coefficient determination system 5 also receives ~~has an input to which~~

distortion data or difference data D_n on a line 102 ~~are supplied~~. The difference data D_n are provided by a subtracter 6 to which the sequence of the compensated digital data y_n is fed from the output of the compensation circuit 2. The ~~S~~subtracter 6 also receives a sequence of digital signal data S_n either directly or indirectly through the test signal check device 4. The sequence of digital signal data S_n corresponds in the configuration phase to a signal map of the test signal, whereby, after appropriate determination of coefficients has been effected, this signal map is as undistorted as possible, or ideally is completely undistorted.

During the configuration phase, the analog test signal $s(t)$ is ~~thus~~ generated and fed to the A/D converter 1. ~~The converter implements an analog-to-digital conversion for which provides the~~ sequence of digital data x_n ~~that is supplied both to the compensation circuit 2 and the coefficient determination circuit 5.~~ If the set of coefficients c_1, \dots, c_K is not available, the compensation circuit 2 outputs the sequence of digital data $x_n = y_n$ as the sequence of compensated digital data y_n (i.e., $y_n = x_n$). This data is fed to the subtracter 6, which ~~that~~ is also supplied with a corresponding sequence of digital test signal data S_n ~~which matches~~ an undistorted data set. After subtraction of the two sequences of data $(y_n - S_n)$, the data sequence of the difference signal D_n on a line 102 is supplied to the coefficient determination system 5. ~~Using this data, coefficient determination system 5 determines the set of coefficients c_1, \dots, c_K, c_0 that is supplied to compensation circuit 2 for future compensation.~~

According to a ~~the~~ preferred embodiment, a test signal $s(t)$ is subsequently sent by the test signal generator 3, which may also be composed of a memory with an analog test signal $s(t)$ and a corresponding digital parameter set s_n , to the A/D converter 1. The sequence of digital data x_n generated by the A/D converter 1 is subsequently compensated by the compensation circuit 2 in accordance with this supplied set of coefficients c_1, \dots, c_K , such that the sequence of compensated

digital data y_n is outputted, ideally with already optimized coefficients c_1, \dots, c_K , without nonlinear distortion. The sequence of compensated digital data y_n is in turn fed to the subtracter 6 in which, after subtraction using the corresponding values of the sequence of digital test signal data S_n , the sequence of data D_n of the difference signal is again generated. This difference data D_n is again fed to the coefficient determination system 5 which, in the event difference data D_n does not equal zero or exceeds predetermined threshold values, implements another, or preferably, an iteratively improved determination of coefficients so as to provide improved coefficients c_1, \dots, c_K .

After a sufficiently distortion-corrected or compensated set of coefficients c_1, \dots, c_K has been determined, the configuration phase ends, after which the circuit composed of the A/D converter 1 and the compensation circuit 2 implements a conversion and compensation of the analog signal $x(t)$ to form a sequence of compensated digital data y_n .

~~Appropriately, a~~ A configuration phase is initiated at regular intervals ~~in order to~~ check the set of coefficients used, c_1, \dots, c_K in terms of their current validity. In this way, drifting nonlinear distortions caused, for example, by the circuit heating up or other interfering effects from the environment can be compensated.

The configuration phase is turned on and off ~~a sufficient number of times as needed~~ so that any slow changes in nonlinear distortions can be detected early enough and then compensated. It is, of course, in principle also possible to implement a predetermination and consideration of anticipated additional degradations or improvements related to the generation of distortions.

A control device 104 C is advantageously employed to control the compensation circuit, the control device 104 being connected to a time-monitoring device, specifically, a timer 106 T. In addition to turning the configuration phase on and off, the control device 104 C also controls the individual components through, for example, a bus 7.

In particular, it is possible to provide different types of test signals $s(t)$, s_n for different application areas of the circuit so that coefficients c_1, \dots, c_K may, for example, be optimally adjusted for a low-frequency or high-frequency analog signal $x(t)$.

The following discussion examines in more detail the circuit components and the operational sequences of the method with reference to the mathematical background.

The configuration phase starts with an analog test signal

——— $s(t)$,

to which the theoretical uncorrupted sampling values

$$S_n = s\left(\frac{n}{F_s}\right),$$

correspond after analog-to-digital conversion, without nonlinear distortion, which values are in turn to be outputted after optimal compensation from the compensation circuit 2 as the sequence of compensated digital data y_n . Here n is a consecutive index of the set of natural numbers, while F_s is the sampling frequency of the A/D converter 1.

After ~~the analog test signal $s(t)$ to A/D has been fed to converter 1 and the analog-to-digital conversion has been performed~~ on the analog test signal $s(t)$ in the converter, the sequence of digital data x_n is supplied to its output based according to the expression

$$x_n = s_n + d_n.$$

The sequence of digital data x_n thus corresponds to the summation of correct theoretical and uncorrupted sampling values s_n , and the respective distortion data value d_n which matches the corresponding distortion by the A/D converter 1.

The ~~D~~digital compensation circuit 2 which uses the coefficients c_1, \dots, c_K to generate the sequence of compensated digital signals y_n that are ultimately to be outputted must therefore perform a compensation having the characteristic that ~~which~~ may be described by a K^{th} -order polynomial:

$$(1) \quad y_n = \sum_{k=1}^K c_k \cdot x_n^k = v \cdot s_n + D_n = S_n + D_n.$$

Here the coefficient values c_k with $k = 1, 2, \dots, K$ are adaptive coefficients, that is, i.e., coefficients which may be adjusted as necessary. The output signal, or sequence of outputted compensated digital data y_n contains a map of the test signal or of the sequence of digital test signal data S_n plus a possible change v , specifically, amplification or ~~distortion~~ attenuation. The sequence of compensated digital data S_n is thus the product of a distortion factor v and the sequence of digital test signal data s_n which may be described by

$$S_n = v \cdot s_n,$$

where the effective distortions of the switching sequence of the A/D converter 1 and, in the event of insufficient compensation, of the compensation circuit 2 may be described by the sequence of difference data D_n according to the expression

$$(2) \quad D_n = y_n - S_n.$$

Since the parameters s_n of the test signal are known, the sequence of output signal data S_n may be extracted from the sequence of compensated digital data y_n by the test signal check device 4 so as to enable the actual distortion data or difference data D_n in data y_n to be calculated at the output of the compensation circuit 2. In addition, the gradients of the rms distortion may be calculated using the expression

$$\frac{\partial D_n^2}{\partial c_k} = 2 \cdot (y_n - S_n) \cdot x_n^k = 2 \cdot D_n \cdot x_n^k.$$

The use of an iterative method allows the set of coefficients c_k to converge. To this end, the formulation

$$(3) \quad c_k^{n+1} = c_k^n - G \cdot D_n \cdot x_n^k$$

may be selected so as ultimately to minimize the rms distortion or output. A parameter G is introduced in equation (3) as a stability criterion, which parameter at the same time provides for the highest possible convergence rate. The term c_k^n ~~here~~ describes the value of the coefficients c_k in the n^{th} iteration step, the coefficient of compensation c_k again having the consecutive index $k = 1, \dots, K$. The iteration steps are preferably counted from the value zero, so that $n = 0, 1, \dots$.

In an especially preferred embodiment, a sinusoidal test signal $s(t) = \sin[2\pi t]$ is preferably used as the test signal to perform the nonlinear compensation since it is then simpler for the A/D converter 1 to determine the structure of the distortions, and is possibly simpler for the compensation circuit 2 to determine additional distortions. A nonlinearly distorting A/D converter 1 having a sinusoidal input signal at a frequency F_t produces harmonics on frequencies $p \cdot F_t$, which may be folded back by sampling to form

$$f_k = \begin{cases} (p \cdot F_t)_{\text{mod } F_s} & (p \cdot F_t)_{\text{mod } F_s} \leq \frac{F_s}{2} \\ F_s - (p \cdot F_t)_{\text{mod } F_s} & (p \cdot F_t)_{\text{mod } F_s} \geq \frac{F_s}{2} \end{cases}$$

Here $p = 2, 3, \dots, M$ is the consecutive index of the frequency calculation.

If the first harmonics are significant, specifically, if $p = 2, \dots, M$ applies, the test frequency F_t should be selected such that the frequency band $2B$ is maximized around the fundamental where none of the first M harmonics fold back according to the expression

$$(4) \quad B = \max_{F_t} \left\{ \min_{p=2, \dots, M} \{ |F_t - fp| \} \right\}.$$

The extraction of the test signal or sequence of output signal data S_n may be implemented using a known method of carrier processing. Another factor which must be taken into account is that

the test signal $s(t)$ or the sequence of output signal data S_n assigned to this signal are amplitude-conforming.

To this end, a circuit may be used that is based on an I/Q demodulator (I: in-phase, Q: quadrature phase) and a Cordic circuit 43, and calculates the phase and amplitude of the input sequence of digital data y_n . ~~FIG. The illustration in Figure-2~~ provides an example of this circuit.

Frequency, amplitude and direct current (DC) are recovered by feedback using the method known from automatic control engineering. A proportional and integral (PI) control ~~complete PI control (PI: proportional and integral components)~~ is employed here to determine the frequency. To determine amplitude and direct current, a TPI-control is used in which only the proportional components are employed. The control parameters used are the P-component of the amplitude control C_a , the P-component for the DC components C_{dc} , and the P-component and I-component of the frequency control C_p or C_i , which components are intended at the same time to meet the stability criterion for a control loop and to ensure the fastest possible transient.

~~The sequence of digital data y_n outputted by compensation circuit 2 is fed to a test signal check device 4,~~ The supplied sequence of digital data y_n is input to being fed to two multipliers 41a, 41b. A sinusoidal signal $\sin[2\pi t]$ as the signal sequence to be multiplied is fed to the first of the multipliers 41a by a sinusoidal tone generator 41. Analogously, a cosine ~~cosinusoidal~~ signal sequence $\cos[2\pi t]$ is supplied by the sinusoidal tone generator to the second multiplier 41b. After multiplication, the two data sequences are each fed to an associated filter 42a, 42b, respectively, ~~filter 42-~~ with undersampling P. After filtering, the I-separated and Q-separated signal components are supplied to a Cordic circuit 43 which determines, ~~for the data y_n outputted from compensation circuit 2,~~ a corresponding amplitude and corresponding phase that are supplied through two outputs.

The ~~signal sequence and data sequence~~ representing the amplitude is input to a subtractor 44a, which also receives a feedback signal on a line 202. The subtractor 44a provides a difference signal to multiplier 44b, which multiplies the difference signal by a coefficient value C_a , and the resultant product is output to a summer 44c. The summer 44c sums the product with the past value. The summer 44c provides a signal sequence to a delay element 44d, which provides a signal sequence to a delay element 44d, which provides an output signal to a multiplier 44e. The multiplier 44e also receives a cosine signal $\cos[2\pi t]$ and provides the resultant product on a line 204. ~~are fed to a series of components 44. These are composed of a subtractor 44a, a multiplier 44b, an adder 44c, and an inverter (z^{-1}) 44e, the output signal of which is fed to subtractor 44a and adder 44c. A coefficient value C_a is supplied as the control parameter for the P-component of amplitude control to the multiplier. The output signal of this series of components is also supplied to another multiplier 44e, to the input of which the cosinusoidal signal $\cos[2\pi t]$ from sinusoidal tone generator 41 is applied. This system is ultimately used to determine the sequence of output signal data S_n that is then supplied to the difference-forming subtractor 6, which in turn has the sequence of digital data y_n applied to it through the second input.~~

~~In addition to amplitude,~~ The Cordic circuit 43 also outputs a corresponding phase or sequence of phase data on a line 206. This data is also fed to a circuit composed of a plurality of components 45. In the embodiment shown, this circuit is composed of two parallel multipliers 45b, 45a to which additionally a coefficient value C_p or a coefficient value C_i is supplied. The output signal of the ~~last-named~~ multiplier 45a is fed to an adder 45c, the output signal of which is supplied both to an inverter (z^{-1}) 45d and to a second adder 45e. The output signal of the inverter 45d is fed to the second input of the ~~first-named~~ adder 45c. Through another input, the second adder 45e receives data from the multiplier 45b in which coefficient value C_p is up-multiplied for the phase data. The

output data from this adder 45e are fed to another adder 45f which has two additional inputs. A frequency ratio F_t/F_s ~~including~~consisting of the test frequency F_t of the A/D converter 1 and the sampling frequency is supplied through the first additional input. An output value of the inverter (z^{-1}) 45g connected after the adder 45f is fed through the second input. Output values of this inverter 45g are supplied as the timing variable t to an input of the sinusoidal tone generator 41.

In addition, a DC component DC_n is filtered out and extracted from the sequence of digital compensated data y_n outputted from the compensation circuit 2. To this end, the digital compensated data y_n are supplied to a circuit 46 composed of a subtracter 46a, a multiplier 46b, an adder 46c, and an inverter (z^{-1}) 46d. A control parameter C_{dc} is applied through the second input to the multiplier 46b. Control parameter C_{dc} determines the rate of the transient. The outputted data sequence from the inverter 46d is supplied to the inputs of the subtracter 46a and the adder 46c, as well as to the subtracter 6 generating the difference data D_n .

~~In the circuit of~~Referring to FIG. figure 2, the frequency F_t is thus derived using a phase-locked loop (PLL). The input signal corresponding to the sequence of compensated digital data y_n is split into I-component and Q-component that are then filtered by a the low-pass filter 42 of critical frequency B and undersampled. From the filtered I-component and Q-component, the Cordic circuit 43 then computes the amplitude and phase between input signal y_n and the locally generated sinusoidal tone from the sinusoidal tone generator 41. The phase is passed to the PI control as the error signal. After a settling time, the sinusoidal tone generator 41 ~~will generate~~s in its cosine branch a signal synchronized with the test tone. The ~~C~~oefficients C_p and C_i , and test frequency F_t as the known parameters determine the PI control.

The amplitude is derived iteratively from the amplitude output of the Cordic circuit 43 using the control parameter C_a . The DC components are filtered and extracted from the output signal using

control parameter C_{dc} . The complete circuit composed of the test signal check device 4 (FIG. 1) and following the subtracter 6 (FIG. 1) finally generates a sequence of difference data D_n according to equation (3) proportional to the nonlinear distortions.

Advantageously, available carrier-processing systems and carrier-processing methods may be utilized for the purpose of implementing this circuit. What must be added are the circuits for the amplitude and DC components.

An especially preferred embodiment of compensation circuit 2 is constructed segment-by-segment, as shown in FIG. figure 3.

The data sequence x_n outputted by the A/D converter 1 is input to the ~~fed in~~ compensation circuit 2 to a parallel system of multipliers 21. At the same time, the same input signal, i.e., once again the corresponding data value of data sequence x_n , is fed to the second input of first multiplier 21₂ so that a squaring is effected. The output of this first multiplier 21₂ is supplied to the input of the second multiplier 21₃, and so on, such that at each subsequent stage the exponent is increased by the value one up to a value x_n^K .

As a result, an exponentiation is effected, where each exponentiation step has an output so that values for digital data with exponentiations $x_n^1, x_n^2, \dots, x_n^K$ are outputted from the input and the field of the multipliers 21. These are then fed to another field of multipliers 22, whereby a multiplication is performed with one each of the corresponding coefficients $e_k(m)c_k(m)$ where $k = 1, 2, \dots, K$. What is described is thus a multi-element system with the coefficients $c_k(m)$ of the compensation in the m^{th} segment with $m = 0, 1, 2, \dots, N-1$ as the m^{th} segment of the amplitude range. Accordingly, the nonexponentiated value or nonexponentiated data sequence x_n^1 as well as the coefficient $c_1(m)$ are entered in the first multiplier 22₁ of the second multiplication field 22. The once exponentiated data value x_n^2 and the second coefficient $c_2(m)$ are entered in the second

multiplier 22₂, etc. The output values of the multipliers 22₁, 22₂, ..., 22_K of second multiplication field 22 are fed to an adder 23 which performs an addition of all input values, and also of the zeroth coefficient $c_0(m)$, then outputs the sequence of compensated digital data y_n .

The sequence of digital data x_n outputted by the A/D converter 1 is also fed to the a coefficient determination system 5, where a rounding operation is performed in an index determination device 51, taking into account the N segments during the determination of the index m. Here the sequence of digital data x_n with its respective value increased by ±one is divided by 2two, then multiplied by the number of segments N. The thus generated segment index m on a line 302 is fed to a coefficient memory system 52 that is composed of a plurality of m parallel memory components 52₀, 52₁, ..., 52_{N-1}. The respective coefficients $c_1(m)$, $c_2(m)$, ..., $c_K(m)$ and $c_0(m)$ are stored in the individual segments of this coefficient memory system 52. For each stored index m, there is an output to an adder 53₁, 53₂, ..., 53_K, 53₀, the output of which in turn is fed back to the same segment of coefficient memory system 52. The result from a multiplier 54₁, 54₂, ..., 54_K is entered in the second input of the adders 53₁, Each correspondingly exponentiated value of the sequence of digital data x_n^1 , x_n^2 , ..., x_n^K is fed to the inputs of these multipliers 54₁, 54₂, ..., 54_K. Supplied to each second input of the multipliers 54₁, 54₂, ..., 54_K is the result of a multiplier 55 to which both the corresponding values for difference data D_n and the negative parameter -G serving as the stability criterion are supplied. Only the value for the difference data D_n , multiplied by the negative parameter -G, is supplied to the adder 53₀ at the adder's second input.

Using a circuit of this type, the compensation circuit 2 may be implemented on a segment-by-segment basis. The range of input data values, that is, the sequence of digital data x_n , from the A/D converter 1 with data values from -1 to +1 is, uniformly distributed among N segments according to the expression

$$-1 + \frac{2}{N}m \leq x_n \leq -1 + \frac{2}{N}(m+1),$$

where the segment index m lies between 0 and $N-1$. As a result, one coefficient set $\{c_0(m), c_1(m), \dots, c_K(m)\}$ is assigned to each segment. Based on segmental interpolation of the characteristic, zeroth coefficients $c_0(m)$ are added in, so that for the sequence of compensated digital data y_n outputted from the compensation circuit 2 the following expression applies:

$$(5) \quad y_n = \sum_{k=0}^K c_k(m) \cdot x_n^k \text{ where } m = \left\lfloor N \cdot \frac{x_n + 1}{2} \right\rfloor,$$

where $\lfloor \cdot \rfloor$ represents the rounding operation.

The equation (5) for compensation in the compensation circuit 2, and the iterative calculation of coefficients according to equation (3) may be effectively implemented together, as FIG. figure 3 illustrates. In a memory of size $N \times (K+1)$, here the coefficient memory system 52, N sets of $K+1$ coefficients each $c_1(m), c_2(m), \dots, c_K(m)$, and $c_0(m)$ are stored for the respective $m = 0, 1, 2, \dots, N-1$. For each sampling instant, the index m is derived according to equation (5) from the input signal, i.e., from the applied value for the sequence of digital data x_n , and assigned to the corresponding coefficient set $52_0, 52_1, \dots, 52_{N-1}$, then applied accordingly within the compensation circuit 2. Also in this procedure, the stored value for each coefficient is iteratively improved according to equation (3) and stored in the same memory location.

As shown in FIG. 4, in a certain case the method with segmental interpolation may be simplified with $N = 2^B$. For this purpose, it is necessary that the number N of segments agree with the resolution of the signal or the sequence of digital data x_n , i.e., $N = 2^B$ applies, where B is the number of bits per sampling value given a signal range between -2^{B-1} and $2^{B-1}-1$ and only one coefficient per segment, i.e., $K = 0$.

The circuit of FIG. 3 is thereby reduced to the circuit of FIG. 4 which has, following the index determination device 51 for determining the index m , a look-up table with 2^B adaptive coefficients $c_0(m)$ in memory fields $52_0, \dots, 52_{N-1}$. In this arrangement, all the multipliers 54 are eliminated so that only the first addition stage with adders $53_1, \dots$ remains, as described above.

Initial synthetic calculations using a sinusoidal tone as the test signal $s(t)$ and a mathematical model of the analog-to-digital characteristic with frequencies $F_s = 40.5$ MHz, $F_t = 1.84$ MHz, the A/D model with coefficients for the calculation based on $0.9895x + 0.0028x^2 + 0.024x^3 - 0.0064x^4$ and for compensation $N = 1$ segments, and a maximum running index of m with $K = 4$, produced significant improvements. After analog-to-digital conversion, the initial value was -60.3 dB, and after compensation the value was 80.9 dB – yielding a significant improvement of 20.5 dB. In the case of one measurement (K3), the improvement found was -47.2 dB after A/D conversion, as compared with -56.3 dB after compensation, giving an improvement of 9.1 dB. The ratio of distortions to outputs after A/D conversion was -46.8 dB, as compared with -55.3 dB after compensation – producing an improvement of 8.4 dB.

In place of a plurality of individual components, as described above, an implementation is also possible in an analogously capable computer chip, or in a monolithically fabricated semiconductor device in the form of an integrated circuit or the like.

Although the present invention has been shown and described with respect to several

preferred embodiments thereof, various changes, omissions and additions to the form and detail thereof, may be made therein, without departing from the spirit and scope of the invention.

What is claimed is:

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